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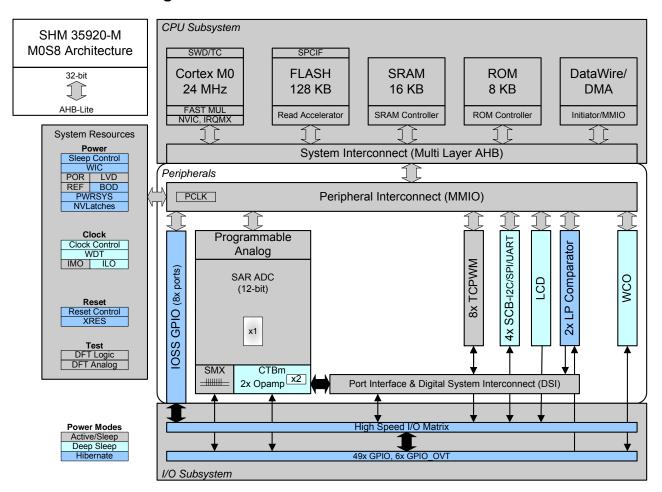
"Embedded - Microcontrollers" refer to small, integrated circuits designed to perform specific tasks within larger systems. These microcontrollers are essentially compact computers on a single chip, containing a processor core, memory, and programmable input/output peripherals. They are called "embedded" because they are embedded within electronic devices to control various functions, rather than serving as standalone computers. Microcontrollers are crucial in modern electronics, providing the intelligence and control needed for a wide range of applications.

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Product Status	Active
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Peripherals	-
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Program Memory Type	-
EEPROM Size	-
RAM Size	
Voltage - Supply (Vcc/Vdd)	-
Data Converters	-
Oscillator Type	-
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## SHM 35920-M Block Diagram



The SHM35920-M devices include extensive support for programming, testing, debugging, and tracing both hardware and firmware.

The ARM Serial Wire Debug (SWD) interface supports all programming and debug features of the device.

Complete debug-on-chip functionality enables full-device debugging in the final system using the standard production device. It does not require special interfaces, debugging pods, simulators, or emulators. Only the standard programming connections are required to fully support debug.

The PSoC Creator Integrated Development Environment (IDE) provides fully integrated programming and debug support for SHM35920-M devices. The SWD interface is fully compatible with industry-standard third-party tools. The SHM35920-M family provides a level of security not possible with multi-chip application solutions or with microcontrollers. This is due to its ability to disable debug features, robust flash protection, and because

it allows customer-proprietary functionality to be implemented in on-chip programmable blocks.

The debug circuits are enabled by default and can only be disabled in firmware. If not enabled, the only way to re-enable them is to erase the entire device, clear flash protection, and reprogram the device with new firmware that enables debugging.

Additionally, all device interfaces can be permanently disabled (device security) for applications concerned about phishing attacks due to a maliciously reprogrammed device or attempts to defeat security by starting and interrupting flash programming sequences. Because all programming, debug, and test interfaces are disabled when maximum device security is enabled, SHM35920-M with device security enabled may not be returned for failure analysis. This is a trade-off the SHM35920-M allows the customer to make.



### **Functional Definition**

### **CPU and Memory Subsystem**

#### CPU

The Cortex-M0 CPU in SHM35920-M is part of the 32-bit MCU subsystem, which is optimized for low-power operation with extensive clock gating. Most instructions are 16 bits in length and execute a subset of the Thumb-2 instruction set. The Cypress implementation includes a hardware multiplier that provides a 32-bit result in one cycle. It includes a nested vectored interrupt controller (NVIC) block with 32 interrupt inputs and also includes a Wakeup Interrupt Controller (WIC), which can wake the processor up from the Deep Sleep mode allowing power to be switched off to the main processor when the chip is in the Deep Sleep mode. The Cortex-M0 CPU provides a Non-Maskable Interrupt (NMI) input, which is made available to the user when it is not in use for system functions requested by the user.

The CPU also includes a debug interface, the serial wire debug (SWD) interface, which is a 2-wire form of JTAG; the debug configuration used for SHM35920-M has four break-point (address) comparators and two watchpoint (data) comparators.

#### Flash

The SHM35920-M has a flash module with a flash accelerator, tightly coupled to the CPU to improve average access times from the flash block. The flash accelerator delivers 85% of single-cycle SRAM access performance on average. Part of the flash module can be used to emulate EEPROM operation if required.

#### **SRAM**

SRAM memory is retained during Hibernate.

#### SROM

A supervisory ROM that contains boot and configuration routines is provided.

#### DMA

A DMA engine, with eight channels, is provided that can do 32-bit transfers and has chainable ping-pong descriptors.

### System Resources

#### Power System

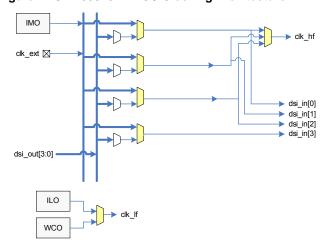
The power system is described in detail in the section Power on page 11. It provides assurance that voltage levels are as required for each respective mode and either delay mode entry (on power-on reset (POR), for example) until voltage levels are as required for proper function or generate resets (brown-out detect (BOD)) or interrupts (low voltage detect (LVD)). SHM35920-M operates with a single external supply over the range of 1.71 to 5.5 V and has five different power modes, transitions between which are managed by the power system. SHM35920-M provides Sleep, Deep Sleep, Hibernate, and Stop low-power modes.

### Clock System

The SHM35920-M clock system is responsible for providing clocks to all subsystems that require clocks and for switching between different clock sources without glitching. In addition, the clock system ensures that no meta-stable conditions occur.

The SHM35920-M clock system consists of a Watch Crystal Oscillator (WCO) running at 32 kHz, the IMO (3 to 48 MHz) and the ILO (32-kHz nominal) internal oscillators, and provision for an external clock.

Figure 1. SHM35920-M MCU Clocking Architecture



The clk\_hf signal can be divided down to generate synchronous clocks for the analog and digital peripherals. There are a total of 16 clock dividers for the SHM35920-M devices, each with 16-bit divide capability. The analog clock leads the digital clocks to allow analog events to occur before digital clock-related noise is generated. The 16-bit capability allows a lot of flexibility in generating fine-grained frequency values and is fully supported in PSoC Creator.

#### IMO Clock Source

The IMO is the primary source of internal clocking in SHM35920-M. It is trimmed during testing to achieve the specified accuracy. Trim values are stored in nonvolatile memory. Trimming can also be done on the fly to allow in-field calibration. The IMO default frequency is 24 MHz and it can be adjusted between 3 to 48 MHz in steps of 1 MHz. IMO tolerance with Cypress-provided calibration settings is ±2%.

### ILO Clock Source

The ILO is a very low power oscillator, nominally 32 kHz, which is primarily used to generate clocks for peripheral operation in Deep Sleep mode. ILO-driven counters can be calibrated to the IMO to improve accuracy. Cypress provides a software component, which does the calibration.

#### Crystal Oscillator

The SHM35920-M clock subsystem also includes a low-frequency crystal oscillator (32-kHz WCO) that is available during the Deep Sleep mode and can be used for Real-Time Clock (RTC) and Watchdog Timer applications.



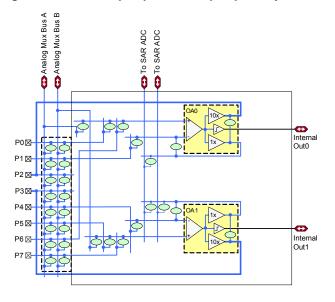
### Analog Multiplex Bus

The SHM35920-M consists of two concentric analog buses (Analog Mux Bus A and Analog Mux Bus B) that circumnavigate the periphery of the chip. These buses can transport analog signals from any pin to various analog blocks (including the opamps) allowing, for example, the ADC to monitor any pin on the chip. These buses are independent and can also be split into three independent sections. This allows one section to be used for general analog signal processing, and another for general-purpose digital peripherals and GPIO.

#### Four Opamps

The SHM35920-M devices have four opamps with comparator modes, which allow most common analog functions to be performed on-chip eliminating external components; PGAs, voltage buffers, filters, trans-impedance amplifiers, and other functions can be realized with external passives saving power, cost, and space. The on-chip opamps are designed with enough bandwidth to drive the Sample-and-Hold circuit of the ADC without requiring external buffering. The opamps can operate in the Deep Sleep mode at very low power levels. The following diagram shows one of two identical opamp pairs of the opamp subsystem.

Figure 3. Identical Opamp Pairs in Opamp Subsystem



The ovals in Figure 3 represent analog switches, which may be controlled via user firmware, the SAR sequencer, or user-defined programmable logic. The opamps (OA0 and OA1) are configurable via these switches to perform all standard opamp functions with appropriate feedback components.

The opamps (OA0 and OA1) are programmable and reconfigurable to provide standard opamp functionality via switchable feedback components, unity gain functionality for driving pins directly, or for internal use (such as buffering SAR ADC inputs as indicated in the diagram), or as true comparators.

The opamp inputs provide highly flexible connectivity and can connect directly to dedicated pins or, via the analog mux buses, to any pin on the chip. Analog switch connectivity is controllable by user firmware.

The opamps operate in Deep Sleep mode at very low currents allowing analog circuits to remain operational during Deep Sleep.

#### Temperature Sensor

All SHM35920-M devices have one on-chip temperature sensor. This consists of a diode, which is biased by a current source that can be disabled to save power. The temperature sensor is connected to the ADC, which digitizes the reading and produces a temperature value using Cypress-supplied software that includes calibration and linearization.

#### Low-power Comparators

The SHM35920-M devices have a pair of low-power comparators, which can also operate in the Deep Sleep and Hibernate modes. This allows the analog system blocks to be disabled while retaining the ability to monitor external voltage levels during low-power modes. The comparator outputs are normally synchronized to avoid meta-stability unless operating in an asynchronous power mode (Hibernate) where the system wake-up circuit is activated by a comparator switch event.

### **Fixed Function Digital**

### Timer/Counter/PWM (TCPWM) Block

The TCPWM block uses a 16-bit counter with user-programmable period length. There is a Capture register to record the count value at the time of an event (which may be an I/O event), a period register which is used to either stop or auto-reload the counter when its count is equal to the period register, and compare registers to generate compare value signals, which are used as PWM duty cycle outputs. The block also provides true and complementary outputs with programmable offset between them to allow use as deadband programmable complementary PWM outputs. It also has a Kill input to force outputs to a predetermined state; for example, this is used in motor drive systems when an overcurrent state is indicated and the PWMs driving the FETs need to be shut off immediately with no time for software intervention. The SHM35920-M has eight TCPWM blocks.

#### Serial Communication Blocks (SCB)

The SHM35920-M has four SCBs, which can each implement an  $I^2$ C. UART, or SPI interface.

I<sup>2</sup>C Mode: The hardware I<sup>2</sup>C block implements a full multi-master and slave interface (it is capable of multimaster arbitration). This block is capable of operating at speeds of up to 1 Mbps (Fast Mode Plus) and has flexible buffering options to reduce interrupt overhead and latency for the CPU. The I<sup>2</sup>C peripheral is also capable of supporting SMBus or PMBus interfaces. In addition, the block supports an 8-deep FIFO for receive and transmit which, by increasing the time given for the CPU to read data, greatly reduces the need for clock stretching caused by the CPU not having read data on time. The FIFO mode is available in all channels and is very useful in the absence of DMA.

The I<sup>2</sup>C peripheral is compatible with the I<sup>2</sup>C Standard-mode, Fast-mode, and Fast-mode Plus devices as defined in the NXP I<sup>2</sup>C-bus specification and user manual (UM10204). The I<sup>2</sup>C bus I/O is implemented with GPIO in open-drain modes.



UART Mode: This is a full-feature UART operating at up to 1 Mbps. It supports automotive single-wire interface (LIN), infrared interface (IrDA), and SmartCard (ISO7816) protocols, all of which are minor variants of the basic UART protocol. In addition, it supports the 9-bit multiprocessor mode that allows addressing of peripherals connected over common RX and TX lines. Common UART functions such as parity error, break detect, and frame error are supported. An 8-deep FIFO allows much greater CPU service latencies to be tolerated.

SPI Mode: The SPI mode supports full Motorola SPI, TI SSP (essentially adds a start pulse used to synchronize SPI Codecs), and National Microwire (half-duplex form of SPI). The SPI block can use the FIFO and also supports an EzSPI mode in which data interchange is reduced to reading and writing an array in memory.

#### **GPIO**

The SHM35920-M has 55 GPIOs in the 68-pin QFN package. The GPIO block implements the following:

- Eight drive strength modes including strong push-pull, resistive pull-up and pull-down, weak (resistive) pull-up and pull-down, open drain and open source, input only, and disabled
- Input threshold select (CMOS or LVTTL)
- Individual control of input and output disables
- Hold mode for latching previous state (used for retaining I/O state in Deep Sleep mode and Hibernate modes)
- Selectable slew rates for dV/dt related noise control to improve FMI

The pins are organized in logical entities called ports, which are 8-bit in width. During power-on and reset, the blocks are forced to the disable state so as not to crowbar any inputs and/or cause excess turn-on current. A multiplexing network known as a high-speed I/O matrix is used to multiplex between various signals that may connect to an I/O pin. Pin locations for fixed-function peripherals are also fixed to reduce internal multiplexing complexity.

Data output and pin state registers store, respectively, the values to be driven on the pins and the states of the pins themselves.

Every I/O pin can generate an interrupt if so enabled and each I/O port has an interrupt request (IRQ) and interrupt service routine (ISR) vector associated with it (8 for SHM35920-M).

The Pins of Port 6 (up to 6 depending on the package) are overvoltage tolerant (V $_{IN}$  can exceed V $_{DD}$ ). The overvoltage cells will not sink more than 10  $\mu$ A when their inputs exceed V $_{DDIO}$  in compliance with I $^2$ C specifications.

### **Special Function Peripherals**

LCD Segment Drive

SHM35920-M has an LCD controller, which can drive up to four commons and up to 51 segments. Any pin can be either a common or a segment pin. It uses full digital methods to drive the LCD segments requiring no generation of internal LCD voltages. The two methods used are referred to as digital correlation and PWMM

Digital correlation pertains to modulating the frequency and levels of the common and segment signals to generate the highest RMS voltage across a segment to light it up or to keep the RMS signal zero. This method is good for STN displays but may result in reduced contrast with TN (cheaper) displays.

PWM pertains to driving the panel with PWM signals to effectively use the capacitance of the panel to provide the integration of the modulated pulse-width to generate the desired LCD voltage. This method results in higher power consumption but can result in better results when driving TN displays. LCD operation is supported during Deep Sleep refreshing a small display buffer (4 bits; 1 32-bit register per port).



Port/Pin	Analog	Alt. Function 1	Alt. Function 2	Alt. Function 3	Alt. Function 4	Alt. Function 5
P6.2		tcpwm.line[5]:0	scb[3].uart_cts:0			scb[3].spi_clk:0
P6.3		tcpwm.line_compl[5]:0	scb[3].uart_rts:0			scb[3].spi_select0:0
P6.4		tcpwm.line[6]:0				scb[3].spi_select1:0
P6.5		tcpwm.line_compl[6]:0				scb[3].spi_select2:0
P3.0		tcpwm.line[0]:0	scb[1].uart_rx:1		scb[1].i2c_scl:2	scb[1].spi_mosi:0
P3.1		tcpwm.line_compl[0]:0	scb[1].uart_tx:1		scb[1].i2c_sda:2	scb[1].spi_miso:0
P3.2		tcpwm.line[1]:0	scb[1].uart_cts:1		swd_data	scb[1].spi_clk:0
P3.3		tcpwm.line_compl[1]:0	scb[1].uart_rts:1		swd_clk	scb[1].spi_select0:0
P3.4		tcpwm.line[2]:0				scb[1].spi_select1:0
P3.5		tcpwm.line_compl[2]:0				scb[1].spi_select2:0
P3.6		tcpwm.line[3]:0				scb[1].spi_select3:0
P3.7		tcpwm.line_compl[3]:0				
P4.0			scb[0].uart_rx:0		scb[0].i2c_scl:1	scb[0].spi_mosi:0
P4.1			scb[0].uart_tx:0		scb[0].i2c_sda:1	scb[0].spi_miso:0
P4.2	csd[0].c_mod		scb[0].uart_cts:0		lpcomp.comp[0]:0	scb[0].spi_clk:0
P4.3	csd[0].c_sh_tank		scb[0].uart_rts:0		lpcomp.comp[1]:0	scb[0].spi_select0:0
P4.4						scb[0].spi_select1:2
P4.5						scb[0].spi_select2:2
P4.6						scb[0].spi_select3:2
P4.7						
P7.0		tcpwm.line[0]:2	scb[3].uart_rx:1		scb[3].i2c_scl:1	scb[3].spi_mosi:1
P7.1		tcpwm.line_compl[0]:2	scb[3].uart_tx:1		scb[3].i2c_sda:1	scb[3].spi_miso:1
P7.2		tcpwm.line[1]:2	scb[3].uart_cts:1			scb[3].spi_clk:1

### Descriptions of the power pin functions are as follows:

**VDDD**: Power supply for both analog and digital sections (where there is no  $V_{DDA}$  pin).

**VDDA**: Analog  $V_{DD}$  pin where package pins allow; shorted to  $V_{DDD}$  otherwise.

**VDDIO:** I/O pin power domain.

VSSA: Analog ground pin where package pins allow; shorted to VSS otherwise

VSS: Ground pin.

VCCD: Regulated Digital supply (1.8 V ±5%).

Port Pins can all be used as LCD Commons, LCD Segment drivers, or CSD sense and shield pins can be connected to AMUXBUS A or B or can all be used as GPIO pins that can be driven by firmware or DSI signals.



### **Power**

The supply voltage range is 1.71 to 5.5 V with all functions and circuits operating over that range.

The SHM35920-M family allows two distinct modes of power supply operation: Unregulated External Supply and Regulated External Supply modes.

### **Unregulated External Supply**

In this mode, the SHM35920-M is powered by an External Power Supply that can be anywhere in the range of 1.8 to 5.5 V. This range is also designed for battery-powered operation, for instance, the chip can be powered from a battery system that starts at 3.5V and works down to 1.8 V. In this mode, the internal regulator of the SHM35920-M supplies the internal logic and the VCCD output of the SHM35920-M must be bypassed to ground via an external Capacitor (in the range of 1 to 1.6  $\mu F;\, X5R$  ceramic or better).

The grounds, VSSA and VSS, must be shorted together. Bypass capacitors must be used from VDDD and VDDA to ground, typical practice for systems in this frequency range is to use a capacitor in the 1  $\mu$ F range in parallel with a smaller capacitor (0.1  $\mu$ F, for example). Note that these are simply rules of thumb and that, for critical applications, the PCB layout, lead inductance, and the Bypass capacitor parasitic should be simulated to design and obtain optimal bypassing.

Power Supply	Bypass Capacitors
VDDD-VSS and VDDIO-VSS	0.1 μF ceramic at each pin plus bulk capacitor 1 to 10 μF.
VDDA-VSSA	0.1 μF ceramic at pin. Additional 1 μF to 10 μF bulk capacitor
VCCD-VSS	1 μF ceramic capacitor at the VCCD pin
VREF-VSSA (optional)	The internal bandgap may be bypassed with a 1 $\mu$ F to 10 $\mu$ F capacitor for better ADC performance.

### **Regulated External Supply**

In this mode, the SHM35920-M is powered by an external power supply that must be within the range of 1.71 to 1.89 V (1.8  $\pm 5\%$ ); note that this range needs to include power supply ripple. VCCD and VDDD pins are shorted together and bypassed. The internal regulator is disabled in firmware.



## **Development Support**

The SHM35920-M family has a rich set of documentation, development tools, and online resources to assist you during your development process.

#### **Documentation**

A suite of documentation supports the SHM35920-M family to ensure that you can find answers to your questions quickly. This section contains a list of some of the key documents.

**Software User Guide**: A step-by-step guide for using PSoC Creator. The software user guide shows you how the PSoC Creator build process works in detail, how to use source control with PSoC Creator, and much more.

**Component Datasheets**: The flexibility of PSoC allows the creation of new peripherals (components) long after the device has gone into production. Component data sheets provide all of the information needed to select and use a particular component, including a functional description, API documentation, example code, and AC/DC specifications.

**Application Notes**: PSoC application notes discuss a particular application of PSoC in depth; examples include temperature monitoring and on-chip filtering. Application notes often include example projects in addition to the application note document.

**Technical Reference Manual**: The Technical Reference Manual (TRM) contains all the technical detail you need to use a PSoC device, including a complete description of all PSoC registers.

#### Online

In addition to print documentation, the Cypress PSoC forums connect you with fellow PSoC users and experts in PSoC from around the world, 24 hours a day, 7 days a week.

#### Tools

With industry standard cores, programming, and debugging interfaces, the SHM35920-M family is part of a development tool ecosystem. Visit us at <a href="https://www.cypress.com/go/psoccreator">www.cypress.com/go/psoccreator</a> for the latest information on the revolutionary, easy to use PSoC Creator IDE, supported third party compilers, programmers, debuggers, and development kits.



# **Electrical Specifications**

### **Absolute Maximum Ratings**

Table 1. Absolute Maximum Ratings<sup>[1]</sup>

			1				•
Spec ID#	Parameter	Description	Min	Тур	Max	Units	Details/Conditions
SID1	V <sub>DD_ABS</sub>	Analog or digital supply relative to V <sub>SS</sub> (V <sub>SSD</sub> = V <sub>SSA</sub> )	-0.5	-	6	V	Absolute maximum
SID2	V <sub>CCD_ABS</sub>	Direct digital core voltage input relative to V <sub>SSD</sub>	-0.5	-	1.95	V	Absolute maximum
SID3	V <sub>GPIO_ABS</sub>	GPIO voltage; V <sub>DDD</sub> or V <sub>DDA</sub>	-0.5	_	V <sub>DD</sub> +0.5	V	Absolute maximum
SID4	I <sub>GPIO_ABS</sub>	Current per GPIO	-25	_	25	mA	Absolute maximum
SID5	I <sub>G-PIO_injection</sub>	GPIO injection current per pin	-0.5	_	0.5	mA	Absolute maximum
BID44	ESD_HBM	Electrostatic discharge human body model	2200	_	_	V	
BID45	ESD_CDM	Electrostatic discharge charged device model	500	_	_	V	
BID46	LU	Pin current for latch-up	-140	_	140	mA	

### **Device Level Specifications**

All specifications are valid for  $-40~^{\circ}\text{C} \le \text{TA} \le 105~^{\circ}\text{C}$  and  $\text{TJ} \le 125~^{\circ}\text{C}$ , except where noted. Specifications are valid for 1.71 V to 5.5 V, except where noted.

Table 2. DC Specifications

Spec ID#	Parameter	Description	Min	Тур	Max	Units	Details / Conditions
SID53	V <sub>DD</sub>	Power Supply Input Voltage ( $V_{DDA} = V_{DDD} = V_{DD}$ )	1.8	_	5.5	V	With regulator enabled
SID255	$V_{DDD}$	Power Supply Input Voltage unregulated	1.71	1.8	1.89	V	Internally unregulated Supply
SID54	V <sub>CCD</sub>	Output voltage (for core logic)	_	1.8	_	V	
SID55	C <sub>EFC</sub>	External Regulator voltage bypass	1	1.3	1.6	μF	X5R ceramic or better
SID56	C <sub>EXC</sub>	Power supply decoupling capacitor	_	1	-	μF	X5R ceramic or better
Active Mod	le, V <sub>DD</sub> = 1.71 \	∕ to 5.5 V, –40 °C to +105 °C		•			-
SID6	I <sub>DD1</sub>	Execute from Flash; CPU at 6 MHz	_	2.2	2.8	mA	
SID7	I <sub>DD2</sub>	Execute from Flash; CPU at 12 MHz	_	3.7	4.2	mA	
SID8	I <sub>DD3</sub>	Execute from Flash; CPU at 24 MHz	_	6.7	7.2	mA	
Sleep Mod	e, -40 °C to +10	05 °C					
SID21	I <sub>DD16</sub>	I <sup>2</sup> C wakeup, WDT, and Comparators on. Regulator Off.	_	1.75	2.1	mA	V <sub>DD</sub> = 1.71 to 1.89, 6 MHz
SID22	I <sub>DD17</sub>	I <sup>2</sup> C wakeup, WDT, and Comparators on.	_	1.7	2.1	mA	V <sub>DD</sub> = 1.8 to 5.5, 6 MHz
SID23	I <sub>DD18</sub>	I <sup>2</sup> C wakeup, WDT, and Comparators on. Regulator Off.	_	2.35	2.8	mA	V <sub>DD</sub> = 1.71 to 1.89, 12 MHz
SID24	I <sub>DD19</sub>	I <sup>2</sup> C wakeup, WDT, and Comparators on.	_	2.25	2.8	mA	V <sub>DD</sub> = 1.8 to 5.5, 12 MHz

#### Note

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Usage above the absolute maximum conditions listed in Table 1 may cause permanent damage to the device. Exposure to absolute maximum conditions for extended periods of time may affect device reliability. The maximum storage temperature is 150 °C in compliance with JEDEC Standard JESD22-A103, High Temperature Storage Life. When used below absolute maximum conditions but above normal operating conditions, the device may not operate to specification.



Table 2. DC Specifications (continued)

Spec ID#	Parameter	Description	Min	Тур	Max	Units	Details / Conditions
Deep Sleep	Mode, -40 °C	to + 60 °C					1
SID30	I <sub>DD25</sub>	I <sup>2</sup> C wakeup and WDT on. Regulator Off.	_	1.55	20	μA	V <sub>DD</sub> = 1.71 to 1.89
SID31	I <sub>DD26</sub>	I <sup>2</sup> C wakeup and WDT on.	_	1.35	15	μΑ	V <sub>DD</sub> = 1.8 to 3.6
SID32	I <sub>DD27</sub>	I <sup>2</sup> C wakeup and WDT on.	_	1.5	15	μΑ	V <sub>DD</sub> = 3.6 to 5.5
Deep Sleep	Mode, +85 °C			l .		I.	1
SID33	I <sub>DD28</sub>	I <sup>2</sup> C wakeup and WDT on. Regulator Off.	_	_	60	μΑ	$V_{DD}$ = 1.71 to 1.89
SID34	I <sub>DD29</sub>	I <sup>2</sup> C wakeup and WDT on.	_	_	45	μΑ	V <sub>DD</sub> = 1.8 to 3.6
SID35	I <sub>DD30</sub>	I <sup>2</sup> C wakeup and WDT on.	_	_	30	μΑ	V <sub>DD</sub> = 3.6 to 5.5
Deep Sleep	Mode, +105 °C			l .		I.	1
SID33Q	I <sub>DD28Q</sub>	I <sup>2</sup> C wakeup and WDT on. Regulator Off.	_	_	135	μΑ	V <sub>DD</sub> = 1.71 to 1.89
SID34Q	I <sub>DD29Q</sub>	I <sup>2</sup> C wakeup and WDT on.	_	_	180	μΑ	V <sub>DD</sub> = 1.8 to 3.6
SID35Q	I <sub>DD30Q</sub>	I <sup>2</sup> C wakeup and WDT on.	_	_	140	μΑ	V <sub>DD</sub> = 3.6 to 5.5
Hibernate N	Node, –40 °C to	+ 60 °C		l .		I.	1
SID39	I <sub>DD34</sub>	Regulator Off.	_	150	3000	nA	V <sub>DD</sub> = 1.71 to 1.89
SID40	I <sub>DD35</sub>		_	150	1000	nA	V <sub>DD</sub> = 1.8 to 3.6
SID41	I <sub>DD36</sub>		_	150	1100	nA	V <sub>DD</sub> = 3.6 to 5.5
Hibernate N	Node, +85 °C			I.	•	l.	1
SID42	I <sub>DD37</sub>	Regulator Off.	_	_	4500	nA	V <sub>DD</sub> = 1.71 to 1.89
SID43	I <sub>DD38</sub>		_	_	3500	nA	V <sub>DD</sub> = 1.8 to 3.6
SID44	I <sub>DD39</sub>		_	_	3500	nA	V <sub>DD</sub> = 3.6 to 5.5
Hibernate N	/lode, +105 °C			I.	•	l.	1
SID42Q	I <sub>DD37Q</sub>	Regulator Off.	_	_	19.4	μΑ	V <sub>DD</sub> = 1.71 to 1.89
SID43Q	I <sub>DD38Q</sub>		_	_	17	μΑ	V <sub>DD</sub> = 1.8 to 3.6
SID44Q	I <sub>DD39Q</sub>		_	_	16	μΑ	V <sub>DD</sub> = 3.6 to 5.5
Stop Mode,	+85 °C				•	I.	1
SID304	I <sub>DD43A</sub>	Stop Mode current; V <sub>DD</sub> = 3.6 V	_	35	85	nA	T = -40 °C to +60 °C
SID304A	I <sub>DD43B</sub>	Stop Mode current; V <sub>DD</sub> = 3.6 V	_	_	1450	nA	T = +85 °C
Stop Mode,	+105 °C						•
SID304Q	I <sub>DD43AQ</sub>	Stop Mode current; V <sub>DD</sub> = 3.6 V	_	_	5645	nA	
XRES curre	ent				1	ı	•
SID307	I <sub>DD_XR</sub>	Supply current while XRES asserted	_	2	5	mA	



Table 3. AC Specifications

Spec ID#	Parameter	Description	Min	Тур	Max	Units	Details/ Conditions
SID48	F <sub>CPU</sub>	CPU frequency	DC	-	24	MHz	$1.71 \le V_{DD} \le 5.5$
SID49	T <sub>SLEEP</sub>	Wakeup from sleep mode	_	0	_	μs	Guaranteed by characterization
SID50	T <sub>DEEPSLEEP</sub>	Wakeup from Deep Sleep mode	_	_	25	μs	24 MHz IMO. Guaranteed by characterization
SID51	T <sub>HIBERNATE</sub>	Wakeup from Hibernate mode	_	_	0.7	ms	Guaranteed by characterization
SID51A	T <sub>STOP</sub>	Wakeup from Stop mode	_	_	2	ms	Guaranteed by characterization
SID52	T <sub>RESETWIDTH</sub>	External reset pulse width	1	_	_	μs	Guaranteed by characterization

**GPIO** 

Table 4. GPIO DC Specifications

Spec ID#	Parameter	Description	Min	Тур	Max	Units	Details/ Conditions
SID57	V <sub>IH</sub> <sup>[2]</sup>	Input voltage high threshold	0.7 × V <sub>DDD</sub>	_	-	V	CMOS Input
SID57A	IIHS	Input current when Pad > V <sub>DDIO</sub> for OVT inputs	-	-	10	μΑ	Per I <sup>2</sup> C Spec
SID58	V <sub>IL</sub>	Input voltage low threshold	_	_	0.3 × V <sub>DDD</sub>	V	CMOS Input
SID241	V <sub>IH</sub> <sup>[2]</sup>	LVTTL input, V <sub>DDD</sub> < 2.7 V	0.7× V <sub>DDD</sub>	_	_	V	
SID242	V <sub>IL</sub>	LVTTL input, V <sub>DDD</sub> < 2.7 V	_	_	0.3 × V <sub>DDD</sub>	V	
SID243	V <sub>IH</sub> <sup>[2]</sup>	LVTTL input, V <sub>DDD</sub> ≥ 2.7 V	2.0	_	-	V	
SID244	V <sub>IL</sub>	LVTTL input, V <sub>DDD</sub> ≥ 2.7 V	_	_	0.8	V	
SID59	V <sub>OH</sub>	Output voltage high level	V <sub>DDD</sub> – 0.6	_	-	V	I <sub>OH</sub> = 4 mA at 3 V V <sub>DDD</sub>
SID60	V <sub>OH</sub>	Output voltage high level	V <sub>DDD</sub> – 0.5	_	_	V	I <sub>OH</sub> = 1 mA at 1.8 V V <sub>DDD</sub>
SID61	V <sub>OL</sub>	Output voltage low level	_	_	0.6	V	I <sub>OL</sub> = 4 mA at 1.8 V V <sub>DDD</sub>
SID62	V <sub>OL</sub>	Output voltage low level	_	_	0.6	V	I <sub>OL</sub> = 8 mAat 3 V V <sub>DDD</sub>
SID62A	V <sub>OL</sub>	Output voltage low level	_	_	0.4	V	I <sub>OL</sub> = 3 mAat 3 V V <sub>DDD</sub>
SID63	R <sub>PULLUP</sub>	Pull-up resistor	3.5	5.6	8.5	kΩ	
SID64	R <sub>PULLDOWN</sub>	Pull-down resistor	3.5	5.6	8.5	kΩ	
SID65	I <sub>IL</sub>	Input leakage current (absolute value)	-	_	2	nA	25 °C, V <sub>DDD</sub> = 3.0 V. Guaranteed by characterization

#### Note

2. V<sub>IH</sub> must not exceed V<sub>DDD</sub> + 0.2 V.

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Table 4. GPIO DC Specifications (continued)

Spec ID#	Parameter	Description	Min	Тур	Max	Units	Details/ Conditions
SID65A	I <sub>IL_CTBM</sub>	Input leakage current (absolute value) for CTBM pins	_	-	4	nA	Guaranteed by characterization
SID66	C <sub>IN</sub>	Input capacitance	_	_	7	pF	
SID67	V <sub>HYSTTL</sub>	Input hysteresis LVTTL	25	40	_	mV	$V_{DDD} \ge 2.7 \text{ V}$
SID68	V <sub>HYSCMOS</sub>	Input hysteresis CMOS	0.05 × V <sub>DDD</sub>	-	_	mV	
SID69	I <sub>DIODE</sub>	Current through protection diode to V <sub>DD</sub> /Vss	_	_	100	μA	Guaranteed by characterization
SID69A	I <sub>TOT_GPIO</sub>	Maximum Total Source or Sink Chip Current	-	_	200	mA	Guaranteed by characterization

### Table 5. GPIO AC Specifications

(Guaranteed by Characterization)[3]

Spec ID#	Parameter	Description	Min	Тур	Max	Units	Details/ Conditions
SID70	T <sub>RISEF</sub>	Rise time in fast strong mode	2	_	12	ns	3.3 V V <sub>DDD</sub> , Cload = 25 pF
SID71	T <sub>FALLF</sub>	Fall time in fast strong mode	2	_	12	ns	3.3 V V <sub>DDD</sub> , Cload = 25 pF
SID72	T <sub>RISES</sub>	Rise time in slow strong mode	10	-	60	ns	3.3 V V <sub>DDD</sub> , Cload = 25 pF
SID73	T <sub>FALLS</sub>	Fall time in slow strong mode	10	-	60	ns	3.3 V V <sub>DDD</sub> , Cload = 25 pF
SID74	F <sub>GPIOUT1</sub>	GPIO Fout;3.3 V $\leq$ V <sub>DDD</sub> $\leq$ 5.5 V. Fast strong mode.	-	-	24	MHz	90/10%, 25 pF load, 60/40 duty cycle
SID75	F <sub>GPIOUT2</sub>	GPIO Fout;1.7 $V \le V_{DDD} \le 3.3 \text{ V. Fast}$ strong mode.	-	-	16.7	MHz	90/10%, 25 pF load, 60/40 duty cycle
SID76	F <sub>GPIOUT3</sub>	GPIO Fout;3.3 V $\leq$ V <sub>DDD</sub> $\leq$ 5.5 V. Slow strong mode.	_	-	7	MHz	90/10%, 25 pF load, 60/40 duty cycle
SID245	F <sub>GPIOUT4</sub>	GPIO Fout;1.7 V $\leq$ V <sub>DDD</sub> $\leq$ 3.3 V. Slow strong mode.	-	-	3.5	MHz	90/10%, 25 pF load, 60/40 duty cycle
SID246	F <sub>GPIOIN</sub>	GPIO input operating frequency; 1.71 V $\leq$ V <sub>DDD</sub> $\leq$ 5.5 V	_	_	48	MHz	90/10% V <sub>IO</sub>

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Note
3. Simultaneous switching transitions on many fully-loaded GPIO pins may cause ground perturbations depending on several factors including PCB and decoupling capacitor design. For applications that are very sensitive to ground perturbations, the slower GPIO slew rate setting may be used.



# **Analog Peripherals**

Opamp

# **Table 8. Opamp Specifications**

(Guaranteed by Characterization)

Spec ID#	Parameter	Description	Min	Тур	Max	Units	Details/ Conditions
	I <sub>DD</sub>	Opamp block current. No load.	_	_	_	_	
SID269	I <sub>DD_HI</sub>	Power = high	-	1100	1850	μA	
SID270	I <sub>DD_MED</sub>	Power = medium	_	550	950	μΑ	
SID271	I <sub>DD_LOW</sub>	Power = low	_	150	350	μΑ	
	GBW	Load = 20 pF, 0.1 mA. V <sub>DDA</sub> = 2.7 V	_	_	_	_	
SID272	GBW_HI	Power = high	6	_	_	MHz	
SID273	GBW_MED	Power = medium	4	_	_	MHz	
SID274	GBW_LO	Power = low	_	1	_	MHz	
	I <sub>OUT_MAX</sub>	V <sub>DDA</sub> ≥2.7 V, 500 mV from rail	_	_	_	_	
SID275	I <sub>OUT_MAX_HI</sub>	Power = high	10	_	_	mA	
SID276	I <sub>OUT_MAX_MID</sub>	Power = medium	10	_	_	mA	
SID277	I <sub>OUT_MAX_LO</sub>	Power = low	_	5	_	mA	
	I <sub>OUT</sub>	V <sub>DDA</sub> = 1.71 V, 500 mV from rail	_	_	_	_	
SID278	I <sub>OUT_MAX_HI</sub>	Power = high	4	_	_	mA	
SID279	I <sub>OUT_MAX_MID</sub>	Power = medium	4	_	_	mA	
SID280	I <sub>OUT_MAX_LO</sub>	Power = low	_	2	_	mA	
SID281	V <sub>IN</sub>	Input voltage range	-0.05	_	VDDA - 0.2	V	Charge-pump on, V <sub>DDA</sub> ≥ 2.7 V
SID282	V <sub>CM</sub>	Input common mode voltage	-0.05	_	VDDA - 0.2	V	Charge-pump on, V <sub>DDA</sub> ≥ 2.7 V
	V <sub>OUT</sub>	V <sub>DDA</sub> ≥ 2.7 V	_	_	_		
SID283	V <sub>OUT_1</sub>	Power = high, Iload=10 mA	0.5	_	VDDA - 0.5	V	
SID284	V <sub>OUT_2</sub>	Power = high, Iload=1 mA	0.2	_	VDDA - 0.2	V	
SID285	V <sub>OUT_3</sub>	Power = medium, Iload=1 mA	0.2	_	VDDA - 0.2	V	
SID286	V <sub>OUT_4</sub>	Power = low, Iload=0.1 mA	0.2	_	VDDA - 0.2	V	
SID288	V <sub>OS_TR</sub>	Offset voltage, trimmed	1	±0.5	1	mV	High mode
SID288A	V <sub>OS_TR</sub>	Offset voltage, trimmed	_	±1	_	mV	Medium mode
SID288B	V <sub>OS_TR</sub>	Offset voltage, trimmed	_	±2	_	mV	Low mode
SID290	V <sub>OS_DR_TR</sub>	Offset voltage drift, trimmed	-10	±3	10	μV/°C	High mode. T <sub>A</sub> ≤ 85 °C.
SID290Q	V <sub>OS_DR_TR</sub>	Offset voltage drift, trimmed	15	±3	15	μV/°C	High mode. T <sub>A</sub> ≤ 105 °C
SID290A	V <sub>OS_DR_TR</sub>	Offset voltage drift, trimmed	_	±10	_	μV/°C	Medium mode
SID290B	V <sub>OS_DR_TR</sub>	Offset voltage drift, trimmed	_	±10	_	μV/°C	Low mode
SID291	CMRR	DC Common mode rejection ratio. High-power mode. Common Model voltage range from 0.5 V to VDDA - 0.5 V.	60	70	-	dB	V <sub>DDD</sub> = 3.6 V
SID292	PSRR	At 1 kHz, 100-mV ripple	70	85	_	dB	V <sub>DDD</sub> = 3.6 V
	Noise		_	_	_	_	

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**Table 8. Opamp Specifications** 

(Guaranteed by Characterization) (continued)

Spec ID#	Parameter	Description	Min	Тур	Max	Units	Details/ Conditions
SID_DS_18	VOS_LOW_M2	Mode 2, Low current	1	5	ı	mV	With trim 25 °C, 0.2 V to V <sub>DDA</sub> -1.5 V
SID_DS_19	IOUT_HI_M1	Mode 1, High current	_	10	ı	mA	Output is 0.5 V to VDDA-0.5 V
SID_DS_20	IOUT_MED_M1	Mode 1, Medium current	_	10	-	mA	Output is 0.5 V to VDDA-0.5 V
SID_DS_21	IOUT_LOW_M1	Mode 1, Low current	_	4	1	mA	Output is 0.5 V to VDDA-0.5 V
SID_DS_22	IOUT_HI_M2	Mode 2, High current	_	1	1	mA	Output is 0.5 V to V <sub>DDA</sub> -0.5 V
SID_DS_23	IOUT_MED_M2	Mode 2, Medium current	-	1	-	mA	Output is 0.5 V to V <sub>DDA</sub> -0.5 V
SID_DS_24	IOUT_LOW_M2	Mode 2, Low current	_	0.5	_	mA	Output is 0.5 V to V <sub>DDA</sub> -0.5 V

### Comparator

Table 9. Comparator DC Specifications

Spec ID#	Parameter	Description	Min	Тур	Max	Units	Details/ Conditions
SID85	V <sub>OFFSET2</sub>	Input offset voltage, Common Mode voltage range from 0 to V <sub>DD</sub> -1	-	_	±4	mV	
SID85A	V <sub>OFFSET3</sub>	Input offset voltage. Ultra low-power mode ( $V_{DDD} \ge 2.2 \text{ V}$ for Temp < 0 °C, $V_{DDD} \ge 1.8 \text{ V}$ for Temp > 0 °C).	-	±12	-	mV	
SID86	V <sub>HYST</sub>	Hysteresis when enabled, Common Mode voltage range from 0 to V <sub>DD</sub> -1.	-	10	35	mV	Guaranteed by characterization
SID87	V <sub>ICM1</sub>	Input common mode voltage in normal mode	0	_	V <sub>DDD</sub> -0.1	V	Modes 1 and 2.
SID247	V <sub>ICM2</sub>	Input common mode voltage in low power mode	0	_	V <sub>DDD</sub>	V	
SID247A	V <sub>ICM3</sub>	Input common mode voltage in ultra low power mode ( $V_{DDD} \ge 2.2 \text{ V for Temp} < 0 ^{\circ}\text{C}, V_{DDD} \ge 1.8 \text{ V for Temp} > 0 ^{\circ}\text{C}$ )	0	_	V <sub>DDD</sub> – 1.15	V	
SID88	CMRR	Common mode rejection ratio	50	-	_	dB	V <sub>DDD</sub> ≥ 2.7 V. Guaranteed by characterization
SID88A	CMRR	Common mode rejection ratio	42	-	_	dB	V <sub>DDD</sub> < 2.7 V. Guaranteed by characterization
SID89	I <sub>CMP1</sub>	Block current, normal mode	_	_	400	μA	Guaranteed by characterization
SID248	I <sub>CMP2</sub>	Block current, low power mode	-	_	100	μA	Guaranteed by characterization
SID259	I <sub>CMP3</sub>	Block current, ultra low power mode (V <sub>DDD</sub> ≥ 2.2 V for Temp < 0 °C, V <sub>DDD</sub> ≥ 1.8 V for Temp > 0 °C)	-	6	28	μA	Guaranteed by characterization
SID90	Z <sub>CMP</sub>	DC input impedance of comparator	35	_	_	МΩ	Guaranteed by characterization

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LCD Direct Drive

### Table 18. LCD Direct Drive DC Specifications

(Guaranteed by Characterization)

Spec ID#	Parameter	Description	Min	Тур	Max	Units	Details/Conditions
SID154	I <sub>LCDLOW</sub>	Operating current in low power mode	_	5	_	μA	16 × 4 small segment disp. at 50 Hz
SID155	C <sub>LCDCAP</sub>	LCD capacitance per segment/common driver	-	500	5000	pF	Guaranteed by Design
SID156	LCD <sub>OFFSET</sub>	Long-term segment offset	_	20	_	mV	
SID157	I <sub>LCDOP1</sub>	PWM Mode current. 5-V bias. 24-MHz IMO	_	0.6	-	mA	32 × 4 segments. 50 Hz, 25 °C
SID158	I <sub>LCDOP2</sub>	PWM Mode current. 3.3-V bias. 24-MHz IMO.	_	0.5	-	mA	32 × 4 segments. 50 Hz, 25 °C

### Table 19. LCD Direct Drive AC Specifications

(Guaranteed by Characterization)

Spec ID#	Parameter	Description	Min	Тур	Max	Units	Details/Conditions
SID159	F <sub>LCD</sub>	LCD frame rate	10	50	150	Hz	

### Table 20. Fixed UART DC Specifications

(Guaranteed by Characterization)

Spec ID#	Parameter	Description	Min	Тур	Max	Units	Details/Conditions
SID160	I <sub>UART1</sub>	Block current consumption at 100 Kbits/sec	_	ı	55	μA	
SID161	I <sub>UART2</sub>	Block current consumption at 1000 Kbits/sec	-	-	312	μA	

### Table 21. Fixed UART AC Specifications

(Guaranteed by Characterization)

Spec ID#	Parameter	Description	Min	Тур	Max	Units	Details/Conditions
SID162	F <sub>UART</sub>	Bit rate	-	_	1	Mbps	

SPI Specifications

### Table 22. Fixed SPI DC Specifications

(Guaranteed by Characterization)

Spec ID#	Parameter	Description	Min	Тур	Max	Units	Details/Conditions
SID163	I <sub>SPI1</sub>	Block current consumption at 1 Mbits/sec	-	-	360	μA	
SID164	I <sub>SPI2</sub>	Block current consumption at 4 Mbits/sec	-	_	560	μA	
SID165	I <sub>SPI3</sub>	Block current consumption at 8 Mbits/sec	-	-	600	μA	

### Table 23. Fixed SPI AC Specifications

(Guaranteed by Characterization)

Spec ID#	Parameter	Description		Тур	Max	Units	Details/Conditions
SID166	F <sub>SPI</sub>	SPI operating frequency (master; 6X oversampling)	_	-	8	MHz	

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### SWD Interface

Table 32. SWD Interface Specifications

Spec ID#	Parameter	Description	Min	Тур	Max	Units	Details/Conditions
SID213	F_SWDCLK1	$3.3~V \leq V_{DD} \leq 5.5~V$	_	1	14	MHz	SWDCLK ≤ 1/3 CPU clock frequency
SID214	F_SWDCLK2	$1.71 \text{ V} \le \text{V}_{DD} \le 3.3 \text{ V}$	_	1	7		SWDCLK ≤ 1/3 CPU clock frequency
SID215	T_SWDI_SETUP	T = 1/f SWDCLK	0.25*T	1	_		Guaranteed by characterization
SID216	T_SWDI_HOLD	T = 1/f SWDCLK	0.25*T	1	-	ns	Guaranteed by characterization
SID217	T_SWDO_VALID	T = 1/f SWDCLK	_	1	0.5*T		Guaranteed by characterization
SID217A	T_SWDO_HOLD	T = 1/f SWDCLK	1		_	ns	Guaranteed by characterization

Internal Main Oscillator

### Table 33. IMO DC Specifications

(Guaranteed by Design)

Spec ID#	Parameter	Description	Min	Тур	Max	Units	Details/Conditions
SID218	I <sub>IMO1</sub>	IMO operating current at 48 MHz	_	_	1000	μΑ	
SID219	I <sub>IMO2</sub>	IMO operating current at 24 MHz	_	_	325	μΑ	
SID220	I <sub>IMO3</sub>	IMO operating current at 12 MHz	_	_	225	μΑ	
SID221	I <sub>IMO4</sub>	IMO operating current at 6 MHz	-	_	180	μΑ	
SID222	I <sub>IMO5</sub>	IMO operating current at 3 MHz	-	_	150	μΑ	

# Table 34. IMO AC Specifications

Spec ID#	Parameter	Description	Min	Тур	Max	Units	Details/Conditions
SID223	F <sub>IMOTOL1</sub>	Frequency variation from 3 to 48 MHz	_	-	±2	%	±3% if T <sub>A</sub> > 85 °C and IMO frequency < 24 MHz
SID226	T <sub>STARTIMO</sub>	IMO startup time	_	_	12	μs	
SID227	T <sub>JITRMSIMO1</sub>	RMS Jitter at 3 MHz	_	156	_	ps	
SID228	T <sub>JITRMSIMO2</sub>	RMS Jitter at 24 MHz	_	145	_	ps	
SID229	T <sub>JITRMSIMO3</sub>	RMS Jitter at 48 MHz	_	139	1	ps	

Internal Low-Speed Oscillator

# Table 35. ILO DC Specifications

(Guaranteed by Design)

Spec ID#	Parameter	Description	Min	Тур	Max	Units	Details/Conditions		
SID231	I <sub>ILO1</sub>	ILO operating current at 32 kHz	_	0.3	1.05	μA	Guaranteed by Characterization		
SID233	I <sub>ILOLEAK</sub>	ILO leakage current	_	2	15	nA	Guaranteed by Design		

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# **Ordering Information**

The SHM35920-M family part numbers and features are listed in the following table.

				MCU	MCU Core							I/C	)	
Part Number	Max CPU Speed (MHz)	Flash (KB)	SRAM (KB)	ADC	IDAC	Opamp	LP Comparator	CSD	Direct LCD Drive	UDBs	TCPWM Blocks	SCB Blocks	GPIO	Package
CYSHM35924I-M068LTI	24	64	8	806 ksps	1× 7-bit 1× 8-bit	2	2	1	~	_	8	4	55	68-QFN
CYSHM35925I-M068LTI	24	128	16	806 ksps	1× 7-bit 1× 8-bit	2	2	_	<b>/</b>	-	8	4	55	68-QFN

The nomenclature used in the preceding table is based on the following part numbering convention:

Field	Description	Values	Meaning
CY	Company ID	CY	Cypress
SHM	Marketing Code	SHM	System Hardware Manager
3	Architecture	3	Third Generation
Α	Product Family	5	Full Programmable
В	Analog Channels	9	Programmable (Limited by IO)
С	Signal Processing Engine: Processing Core	2	ARM Cortex M0
		2	16 KB
	Signal Processing Engine: Flash Size	3	32 KB
D		4	64 KB
		5	128 KB
		6	256 KB
Е	Product Type		Intelligent Analog
_		Р	Programmable Analog
	Device Class	S	SHM 35000 S-Class
F		М	SHM 35000 M-Class
		L	SHM 35000 L-Class
GHI	Package Pins	000-999	Number of Pins on Package
	Package Type	BZ	BGA
		AX	TQFP
JK		LT	QFN
		PV	SSOP
		FN	CSP
L	Temperature Grade	I	Industrial
М	Tape and Reel	Т	Tape and Reel N/A for other packages

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# **Acronyms**

Table 44. Acronyms Used in this Document

Acronym	Description	
abus	analog local bus	
ADC	analog-to-digital converter	
AG	analog global	
АНВ	AMBA (advanced microcontroller bus architecture) high-performance bus, an ARM data transfer bus	
ALU	arithmetic logic unit	
AMUXBUS	analog multiplexer bus	
API	application programming interface	
APSR	application program status register	
ARM <sup>®</sup>	advanced RISC machine, a CPU architecture	
ATM	automatic thump mode	
BW	bandwidth	
CAN	Controller Area Network, a communications protocol	
CMRR	common-mode rejection ratio	
CPU	central processing unit	
CRC	cyclic redundancy check, an error-checking protocol	
DAC	digital-to-analog converter, see also IDAC, VDAC	
DFB	digital filter block	
DIO	digital input/output, GPIO with only digital capabilities, no analog. See GPIO.	
DMIPS	Dhrystone million instructions per second	
DMA	direct memory access, see also TD	
DNL	differential nonlinearity, see also INL	
DNU	do not use	
DR	port write data registers	
DSI	digital system interconnect	
DWT	data watchpoint and trace	
ECC	error correcting code	
ECO	external crystal oscillator	
EEPROM	electrically erasable programmable read-only memory	
EMI	electromagnetic interference	
EMIF	external memory interface	
EOC	end of conversion	
EOF	end of frame	
EPSR	execution program status register	
ESD	electrostatic discharge	

Table 44. Acronyms Used in this Document (continued)

ETM embedded trace macrocell  FIR finite impulse response, see also IIR  FPB flash patch and breakpoint  FS full-speed  GPIO general-purpose input/output, applies to a PSoC pin  HVI high-voltage interrupt, see also LVI, LVD  IC integrated circuit  IDAC current DAC, see also DAC, VDAC  IDE integrated development environment  I²C, or IIC Inter-Integrated Circuit, a communications protocol  IIR infinite impulse response, see also FIR  ILO internal low-speed oscillator, see also IMO  IMO internal main oscillator, see also IMO  INL integral nonlinearity, see also DNL  I/O input/output, see also GPIO, DIO, SIO, USBIO  IPOR initial power-on reset  IPSR interrupt program status register  IRQ interrupt request  ITM instrumentation trace macrocell  LCD liquid crystal display  LIN Local Interconnect Network, a communications protocol.  LR link register  LUT lookup table  LVD low-voltage detect, see also LVI  LVI low-voltage interrupt, see also HVI  LVTTL low-voltage transistor-transistor logic  MAC multiply-accumulate  MCU microcontroller unit  MISO master-in slave-out  NC no connect  NMI nonmaskable interrupt  NRZ non-return-to-zero  NVIC nested vectored interrupt controller  NVL nonvolatile latch, see also WOL  opamp operational amplifier  PAL programmable array logic, see also PLD  PC program counter	Acronym	Description
FPB flash patch and breakpoint  FS full-speed  GPIO general-purpose input/output, applies to a PSoC pin  HVI high-voltage interrupt, see also LVI, LVD  IC integrated circuit  IDAC current DAC, see also DAC, VDAC  IDE integrated development environment  I²C, or IIC Inter-Integrated Circuit, a communications protocol  IIR infinite impulse response, see also FIR  ILO internal low-speed oscillator, see also IMO  IMO internal main oscillator, see also ILO  INL integral nonlinearity, see also DNL  I/O input/output, see also GPIO, DIO, SIO, USBIO  IPOR initial power-on reset  IPSR interrupt program status register  IRQ interrupt request  ITM instrumentation trace macrocell  LCD liquid crystal display  LIN Local Interconnect Network, a communications protocol.  LR link register  LUT lookup table  LVD low-voltage detect, see also LVI  LVI low-voltage interrupt, see also HVI  LVTTL low-voltage transistor-transistor logic  MAC multiply-accumulate  MCU microcontroller unit  MISO master-in slave-out  NC no connect  NMI nonmaskable interrupt  NRZ non-return-to-zero  NVIC nested vectored interrupt controller  NVL nonvolatile latch, see also WOL  opamp operational amplifier  PAL programmable array logic, see also PLD  PC	ETM	embedded trace macrocell
FS full-speed GPIO general-purpose input/output, applies to a PSoC pin  HVI high-voltage interrupt, see also LVI, LVD  IC integrated circuit  IDAC current DAC, see also DAC, VDAC  IDE integrated development environment  I²C, or IIC Inter-Integrated Circuit, a communications protocol  IIR infinite impulse response, see also FIR  ILO internal low-speed oscillator, see also IMO  IMO internal main oscillator, see also IMO  IMO integral nonlinearity, see also DNL  I/O input/output, see also GPIO, DIO, SIO, USBIO  IPOR initial power-on reset  IPSR interrupt program status register  IRQ interrupt request  ITM instrumentation trace macrocell  LCD liquid crystal display  LIN Local Interconnect Network, a communications protocol.  LR link register  LUT lookup table  LVD low-voltage detect, see also LVI  LVI low-voltage interrupt, see also HVI  LVTTL low-voltage transistor-transistor logic  MAC multiply-accumulate  MCU microcontroller unit  MISO master-in slave-out  NC no connect  NMI nonmaskable interrupt  NRZ non-return-to-zero  NVIC nested vectored interrupt controller  NVL nonvolatile latch, see also WOL  opamp operational amplifier  PAL programmable array logic, see also PLD  PC program counter	FIR	finite impulse response, see also IIR
GPIO general-purpose input/output, applies to a PSoC pin  HVI high-voltage interrupt, see also LVI, LVD  IC integrated circuit  IDAC current DAC, see also DAC, VDAC  IDE integrated development environment  I <sup>2</sup> C, or IIC Inter-Integrated Circuit, a communications protocol  IIR infinite impulse response, see also FIR  ILO internal low-speed oscillator, see also IMO  IMO internal main oscillator, see also IMO  IMO integral nonlinearity, see also DNL  I/O input/output, see also GPIO, DIO, SIO, USBIO  IPOR initial power-on reset  IPSR interrupt program status register  IRQ interrupt request  ITM instrumentation trace macrocell  LCD liquid crystal display  LIN Local Interconnect Network, a communications protocol.  LR link register  LUT lookup table  LVD low-voltage detect, see also LVI  LVI low-voltage interrupt, see also HVI  LVTTL low-voltage transistor-transistor logic  MAC multiply-accumulate  MCU microcontroller unit  MISO master-in slave-out  NC no connect  NMI nonmaskable interrupt  NRZ non-return-to-zero  NVIC nested vectored interrupt controller  NVL nonvolatile latch, see also WOL  opamp operational amplifier  PAL programmable array logic, see also PLD  PC program counter	FPB	flash patch and breakpoint
pin HVI high-voltage interrupt, see also LVI, LVD IC integrated circuit IDAC current DAC, see also DAC, VDAC IDE integrated development environment I <sup>2</sup> C, or IIC Inter-Integrated Circuit, a communications protocol IIR infinite impulse response, see also FIR ILO internal low-speed oscillator, see also IMO IMO internal main oscillator, see also ILO INL integral nonlinearity, see also DNL I/O input/output, see also GPIO, DIO, SIO, USBIO IPOR initial power-on reset IPSR interrupt program status register IRQ interrupt request ITM instrumentation trace macrocell LCD liquid crystal display LIN Local Interconnect Network, a communications protocol. LR link register LUT lookup table LVD low-voltage detect, see also LVI LVI low-voltage interrupt, see also HVI LVTTL low-voltage transistor-transistor logic MAC multiply-accumulate MCU microcontroller unit MISO master-in slave-out NC no connect NMI nonmaskable interrupt NRZ non-return-to-zero NVIC nested vectored interrupt controller NVL nonvolatile latch, see also WOL opamp operational amplifier PAL programmable array logic, see also PLD PC program counter	FS	full-speed
IC integrated circuit IDAC current DAC, see also DAC, VDAC IDE integrated development environment I <sup>2</sup> C, or IIC Inter-Integrated Circuit, a communications protocol IIR infinite impulse response, see also FIR ILO internal low-speed oscillator, see also IMO IMO internal main oscillator, see also ILO INL integral nonlinearity, see also DNL I/O input/output, see also GPIO, DIO, SIO, USBIO IPOR initial power-on reset IPSR interrupt program status register IRQ interrupt request ITM instrumentation trace macrocell LCD liquid crystal display LIN Local Interconnect Network, a communications protocol. LR link register LUT lookup table LVD low-voltage detect, see also LVI LVI low-voltage interrupt, see also HVI LVTTL low-voltage interrupt, see also HVI LVTTL low-voltage transistor-transistor logic MAC multiply-accumulate MCU microcontroller unit MISO master-in slave-out NC no connect NMI nonmaskable interrupt NRZ non-return-to-zero NVIC nested vectored interrupt controller NVL nonvolatile latch, see also WOL opamp operational amplifier PAL programmable array logic, see also PLD PC program counter	GPIO	17.
IDAC current DAC, see also DAC, VDAC IDE integrated development environment I²C, or IIC Inter-Integrated Circuit, a communications protocol IIR infinite impulse response, see also FIR ILO internal low-speed oscillator, see also IMO IMO internal main oscillator, see also ILO INL integral nonlinearity, see also DNL I/O input/output, see also GPIO, DIO, SIO, USBIO IPOR initial power-on reset IPSR interrupt program status register IRQ interrupt request ITM instrumentation trace macrocell LCD liquid crystal display LIN Local Interconnect Network, a communications protocol. LR link register LUT lookup table LVD low-voltage detect, see also LVI LVI low-voltage interrupt, see also HVI LVTTL low-voltage interrupt, see also HVI LVTTL low-voltage transistor-transistor logic MAC multiply-accumulate MCU microcontroller unit MISO master-in slave-out NC no connect NMI nonmaskable interrupt NRZ non-return-to-zero NVIC nested vectored interrupt controller NVL nonvolatile latch, see also WOL opamp operational amplifier PAL programmable array logic, see also PLD PC program counter	HVI	high-voltage interrupt, see also LVI, LVD
IDE integrated development environment  I <sup>2</sup> C, or IIC Inter-Integrated Circuit, a communications protocol  IIR infinite impulse response, see also FIR  ILO internal low-speed oscillator, see also IMO  IMO internal main oscillator, see also IMO  IMO integral nonlinearity, see also DNL  I/O input/output, see also GPIO, DIO, SIO, USBIO  IPOR initial power-on reset  IPSR interrupt program status register  IRQ interrupt request  ITM instrumentation trace macrocell  LCD liquid crystal display  LIN Local Interconnect Network, a communications protocol.  LR link register  LUT lookup table  LVD low-voltage detect, see also LVI  LVI low-voltage interrupt, see also HVI  LVTTL low-voltage transistor-transistor logic  MAC multiply-accumulate  MCU microcontroller unit  MISO master-in slave-out  NC no connect  NMI nonmaskable interrupt  NRZ non-return-to-zero  NVIC nested vectored interrupt controller  NVL nonvolatile latch, see also WOL  opamp operational amplifier  PAL programmable array logic, see also PLD  PC program counter	IC	integrated circuit
I <sup>2</sup> C, or IIC Inter-Integrated Circuit, a communications protocol  IIR infinite impulse response, see also FIR  ILO internal low-speed oscillator, see also IMO  IMO internal main oscillator, see also ILO  INL integral nonlinearity, see also DNL  I/O input/output, see also GPIO, DIO, SIO, USBIO  IPOR initial power-on reset  IPSR interrupt program status register  IRQ interrupt request  ITM instrumentation trace macrocell  LCD liquid crystal display  LIN Local Interconnect Network, a communications protocol.  LR link register  LUT lookup table  LVD low-voltage detect, see also LVI  LVI low-voltage interrupt, see also HVI  LVTTL low-voltage transistor-transistor logic  MAC multiply-accumulate  MCU microcontroller unit  MISO master-in slave-out  NC no connect  NMI nonmaskable interrupt  NRZ non-return-to-zero  NVIC nested vectored interrupt controller  NVL nonvolatile latch, see also WOL  opamp operational amplifier  PAL programmable array logic, see also PLD  PC program counter	IDAC	current DAC, see also DAC, VDAC
IIR infinite impulse response, see also FIR ILO internal low-speed oscillator, see also IMO IMO internal main oscillator, see also ILO INL integral nonlinearity, see also DNL I/O input/output, see also GPIO, DIO, SIO, USBIO IPOR initial power-on reset IPSR interrupt program status register IRQ interrupt request ITM instrumentation trace macrocell LCD liquid crystal display LIN Local Interconnect Network, a communications protocol. LR link register LUT lookup table LVD low-voltage detect, see also LVI LVI low-voltage interrupt, see also HVI LVTTL low-voltage transistor-transistor logic MAC multiply-accumulate MCU microcontroller unit MISO master-in slave-out NC no connect NMI nonmaskable interrupt NRZ non-return-to-zero NVIC nested vectored interrupt controller NVL nonvolatile latch, see also WOL Opamp operational amplifier PAL programmable array logic, see also PLD PC program counter	IDE	integrated development environment
ILO internal low-speed oscillator, see also IMO internal main oscillator, see also ILO INL integral nonlinearity, see also DNL I/O input/output, see also GPIO, DIO, SIO, USBIO IPOR initial power-on reset IPSR interrupt program status register IRQ interrupt request ITM instrumentation trace macrocell IcD Iiquid crystal display IIN Local Interconnect Network, a communications protocol.  LR Iink register IUT lookup table IVD low-voltage detect, see also LVI IVI low-voltage interrupt, see also HVI IVTIL low-voltage transistor-transistor logic MAC multiply-accumulate MCU microcontroller unit MISO master-in slave-out NC no connect NMI nonmaskable interrupt controller NVL nonvolatile latch, see also WOL opamp operational amplifier PAL programmable array logic, see also PLD PC program counter	I <sup>2</sup> C, or IIC	
IMO internal main oscillator, see also ILO INL integral nonlinearity, see also DNL I/O input/output, see also GPIO, DIO, SIO, USBIO IPOR initial power-on reset IPSR interrupt program status register IRQ interrupt request ITM instrumentation trace macrocell LCD liquid crystal display LIN Local Interconnect Network, a communications protocol. LR link register LUT lookup table LVD low-voltage detect, see also LVI LVI low-voltage interrupt, see also HVI LVTTL low-voltage transistor-transistor logic MAC multiply-accumulate MCU microcontroller unit MISO master-in slave-out NC no connect NMI nonmaskable interrupt NRZ non-return-to-zero NVIC nested vectored interrupt controller NVL nonvolatile latch, see also WOL opamp operational amplifier PAL programmable array logic, see also PLD PC program counter	IIR	infinite impulse response, see also FIR
INL integral nonlinearity, see also DNL  I/O input/output, see also GPIO, DIO, SIO, USBIO  IPOR initial power-on reset  IPSR interrupt program status register  IRQ interrupt request  ITM instrumentation trace macrocell  LCD liquid crystal display  LIN Local Interconnect Network, a communications protocol.  LR link register  LUT lookup table  LVD low-voltage detect, see also LVI  LVI low-voltage interrupt, see also HVI  LVTTL low-voltage transistor-transistor logic  MAC multiply-accumulate  MCU microcontroller unit  MISO master-in slave-out  NC no connect  NMI nonmaskable interrupt  NRZ non-return-to-zero  NVIC nested vectored interrupt controller  NVL nonvolatile latch, see also WOL  opamp operational amplifier  PAL programmable array logic, see also PLD  PC program counter	ILO	internal low-speed oscillator, see also IMO
I/O input/output, see also GPIO, DIO, SIO, USBIO IPOR initial power-on reset IPSR interrupt program status register IRQ interrupt request ITM instrumentation trace macrocell IcD liquid crystal display Local Interconnect Network, a communications protocol.  LR link register LUT lookup table LVD low-voltage detect, see also LVI LVI low-voltage interrupt, see also HVI LVTTL low-voltage transistor-transistor logic MAC multiply-accumulate MCU microcontroller unit MISO master-in slave-out NC no connect NMI nonmaskable interrupt NRZ non-return-to-zero NVIC nested vectored interrupt controller NVL nonvolatile latch, see also WOL programmable array logic, see also PLD PC program counter	IMO	internal main oscillator, see also ILO
IPOR initial power-on reset IPSR interrupt program status register IRQ interrupt request ITM instrumentation trace macrocell LCD liquid crystal display LIN Local Interconnect Network, a communications protocol. LR link register LUT lookup table LVD low-voltage detect, see also LVI LVI low-voltage interrupt, see also HVI LVTTL low-voltage transistor-transistor logic MAC multiply-accumulate MCU microcontroller unit MISO master-in slave-out NC no connect NMI nonmaskable interrupt NRZ non-return-to-zero NVIC nested vectored interrupt controller NVL nonvolatile latch, see also WOL opamp operational amplifier PAL programmable array logic, see also PLD PC program counter	INL	integral nonlinearity, see also DNL
IPSR interrupt program status register IRQ interrupt request ITM instrumentation trace macrocell LCD liquid crystal display LIN Local Interconnect Network, a communications protocol. LR link register LUT lookup table LVD low-voltage detect, see also LVI LVI low-voltage interrupt, see also HVI LVTTL low-voltage transistor-transistor logic MAC multiply-accumulate MCU microcontroller unit MISO master-in slave-out NC no connect NMI nonmaskable interrupt NRZ non-return-to-zero NVIC nested vectored interrupt controller NVL nonvolatile latch, see also WOL opamp operational amplifier PAL programmable array logic, see also PLD PC program counter	I/O	input/output, see also GPIO, DIO, SIO, USBIO
IRQ interrupt request ITM instrumentation trace macrocell LCD liquid crystal display LIN Local Interconnect Network, a communications protocol. LR link register LUT lookup table LVD low-voltage detect, see also LVI LVI low-voltage interrupt, see also HVI LVTTL low-voltage transistor-transistor logic MAC multiply-accumulate MCU microcontroller unit MISO master-in slave-out NC no connect NMI nonmaskable interrupt NRZ non-return-to-zero NVIC nested vectored interrupt controller NVL nonvolatile latch, see also WOL opamp operational amplifier PAL programmable array logic, see also PLD PC program counter	IPOR	initial power-on reset
ITM instrumentation trace macrocell  LCD liquid crystal display  LIN Local Interconnect Network, a communications protocol.  LR link register  LUT lookup table  LVD low-voltage detect, see also LVI  LVI low-voltage interrupt, see also HVI  LVTTL low-voltage transistor-transistor logic  MAC multiply-accumulate  MCU microcontroller unit  MISO master-in slave-out  NC no connect  NMI nonmaskable interrupt  NRZ non-return-to-zero  NVIC nested vectored interrupt controller  NVL nonvolatile latch, see also WOL  opamp operational amplifier  PAL programmable array logic, see also PLD  PC program counter	IPSR	interrupt program status register
LCD liquid crystal display  LIN Local Interconnect Network, a communications protocol.  LR link register  LUT lookup table  LVD low-voltage detect, see also LVI  LVI low-voltage interrupt, see also HVI  LVTTL low-voltage transistor-transistor logic  MAC multiply-accumulate  MCU microcontroller unit  MISO master-in slave-out  NC no connect  NMI nonmaskable interrupt  NRZ non-return-to-zero  NVIC nested vectored interrupt controller  NVL nonvolatile latch, see also WOL  opamp operational amplifier  PAL programmable array logic, see also PLD  PC program counter	IRQ	interrupt request
LIN Local Interconnect Network, a communications protocol.  LR link register  LUT lookup table  LVD low-voltage detect, see also LVI  LVI low-voltage interrupt, see also HVI  LVTTL low-voltage transistor-transistor logic  MAC multiply-accumulate  MCU microcontroller unit  MISO master-in slave-out  NC no connect  NMI nonmaskable interrupt  NRZ non-return-to-zero  NVIC nested vectored interrupt controller  NVL nonvolatile latch, see also WOL  opamp operational amplifier  PAL programmable array logic, see also PLD  PC program counter	ITM	instrumentation trace macrocell
LR link register  LUT lookup table  LVD low-voltage detect, see also LVI  LVI low-voltage interrupt, see also HVI  LVTTL low-voltage transistor-transistor logic  MAC multiply-accumulate  MCU microcontroller unit  MISO master-in slave-out  NC no connect  NMI nonmaskable interrupt  NRZ non-return-to-zero  NVIC nested vectored interrupt controller  NVL nonvolatile latch, see also WOL  opamp operational amplifier  PAL programmable array logic, see also PLD  PC program counter	LCD	liquid crystal display
LUT lookup table  LVD low-voltage detect, see also LVI  LVI low-voltage interrupt, see also HVI  LVTTL low-voltage transistor-transistor logic  MAC multiply-accumulate  MCU microcontroller unit  MISO master-in slave-out  NC no connect  NMI nonmaskable interrupt  NRZ non-return-to-zero  NVIC nested vectored interrupt controller  NVL nonvolatile latch, see also WOL  opamp operational amplifier  PAL programmable array logic, see also PLD  PC program counter	LIN	
LVD low-voltage detect, see also LVI LVI low-voltage interrupt, see also HVI LVTTL low-voltage transistor-transistor logic MAC multiply-accumulate MCU microcontroller unit MISO master-in slave-out NC no connect NMI nonmaskable interrupt NRZ non-return-to-zero NVIC nested vectored interrupt controller NVL nonvolatile latch, see also WOL opamp operational amplifier PAL programmable array logic, see also PLD PC program counter	LR	link register
LVI low-voltage interrupt, see also HVI LVTTL low-voltage transistor-transistor logic MAC multiply-accumulate MCU microcontroller unit MISO master-in slave-out NC no connect NMI nonmaskable interrupt NRZ non-return-to-zero NVIC nested vectored interrupt controller NVL nonvolatile latch, see also WOL opamp operational amplifier PAL programmable array logic, see also PLD PC program counter	LUT	lookup table
LVTTL low-voltage transistor-transistor logic  MAC multiply-accumulate  MCU microcontroller unit  MISO master-in slave-out  NC no connect  NMI nonmaskable interrupt  NRZ non-return-to-zero  NVIC nested vectored interrupt controller  NVL nonvolatile latch, see also WOL  opamp operational amplifier  PAL programmable array logic, see also PLD  PC program counter	LVD	low-voltage detect, see also LVI
MAC multiply-accumulate  MCU microcontroller unit  MISO master-in slave-out  NC no connect  NMI nonmaskable interrupt  NRZ non-return-to-zero  NVIC nested vectored interrupt controller  NVL nonvolatile latch, see also WOL  opamp operational amplifier  PAL programmable array logic, see also PLD  PC program counter	LVI	low-voltage interrupt, see also HVI
MCU microcontroller unit  MISO master-in slave-out  NC no connect  NMI nonmaskable interrupt  NRZ non-return-to-zero  NVIC nested vectored interrupt controller  NVL nonvolatile latch, see also WOL  opamp operational amplifier  PAL programmable array logic, see also PLD  PC program counter	LVTTL	low-voltage transistor-transistor logic
MISO master-in slave-out  NC no connect  NMI nonmaskable interrupt  NRZ non-return-to-zero  NVIC nested vectored interrupt controller  NVL nonvolatile latch, see also WOL  opamp operational amplifier  PAL programmable array logic, see also PLD  PC program counter	MAC	multiply-accumulate
NC no connect  NMI nonmaskable interrupt  NRZ non-return-to-zero  NVIC nested vectored interrupt controller  NVL nonvolatile latch, see also WOL  opamp operational amplifier  PAL programmable array logic, see also PLD  PC program counter	MCU	microcontroller unit
NMI nonmaskable interrupt  NRZ non-return-to-zero  NVIC nested vectored interrupt controller  NVL nonvolatile latch, see also WOL  opamp operational amplifier  PAL programmable array logic, see also PLD  PC program counter	MISO	master-in slave-out
NRZ non-return-to-zero  NVIC nested vectored interrupt controller  NVL nonvolatile latch, see also WOL  opamp operational amplifier  PAL programmable array logic, see also PLD  PC program counter	NC	no connect
NVIC nested vectored interrupt controller  NVL nonvolatile latch, see also WOL  opamp operational amplifier  PAL programmable array logic, see also PLD  PC program counter	NMI	nonmaskable interrupt
NVL nonvolatile latch, see also WOL opamp operational amplifier PAL programmable array logic, see also PLD PC program counter	NRZ	non-return-to-zero
opamp operational amplifier  PAL programmable array logic, see also PLD  PC program counter	NVIC	nested vectored interrupt controller
PAL programmable array logic, see also PLD PC program counter	NVL	nonvolatile latch, see also WOL
PC program counter	opamp	operational amplifier
1 10 1 11 11	PAL	programmable array logic, see also PLD
PCB printed circuit board	PC	program counter
	PCB	printed circuit board

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Table 44. Acronyms Used in this Document (continued)

Acronym	Description
PGA	programmable gain amplifier
PHUB	peripheral hub
PHY	physical layer
PICU	port interrupt control unit
PLA	programmable logic array
PLD	programmable logic device, see also PAL
PLL	phase-locked loop
PMDD	package material declaration data sheet
POR	power-on reset
PRES	precise power-on reset
PRS	pseudo random sequence
PS	port read data register
PSoC <sup>®</sup>	Programmable System-on-Chip™
PSRR	power supply rejection ratio
PWM	pulse-width modulator
RAM	random-access memory
RISC	reduced-instruction-set computing
RMS	root-mean-square
RTC	real-time clock
RTL	register transfer language
RTR	remote transmission request
RX	receive
SAR	successive approximation register
SC/CT	switched capacitor/continuous time
SCL	I <sup>2</sup> C serial clock
SDA	I <sup>2</sup> C serial data
S/H	sample and hold
SINAD	signal to noise and distortion ratio
SIO	special input/output, GPIO with advanced features. See GPIO.
SOC	start of conversion
SOF	start of frame
SPI	Serial Peripheral Interface, a communications protocol
SR	slew rate
SRAM	static random access memory
SRES	software reset
SWD	serial wire debug, a test protocol
SWV	single-wire viewer
TD	transaction descriptor, see also DMA

Table 44. Acronyms Used in this Document (continued)

Acronym	Description
THD	total harmonic distortion
TIA	transimpedance amplifier
TRM	technical reference manual
TTL	transistor-transistor logic
TX	transmit
UART	Universal Asynchronous Transmitter Receiver, a communications protocol
UDB	universal digital block
USB	Universal Serial Bus
USBIO	USB input/output, PSoC pins used to connect to a USB port
VDAC	voltage DAC, see also DAC, IDAC
WDT	watchdog timer
WOL	write once latch, see also NVL
WRES	watchdog timer reset
XRES	external reset I/O pin
XTAL	crystal

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# **Document Conventions**

### **Units of Measure**

### Table 45. Units of Measure

Symbol	Unit of Measure
°C	degrees Celsius
dB	decibel
fF	femto farad
Hz	hertz
KB	1024 bytes
kbps	kilobits per second
Khr	kilohour
kHz	kilohertz
kΩ	kilo ohm
ksps	kilosamples per second
LSB	least significant bit
Mbps	megabits per second
MHz	megahertz
ΜΩ	mega-ohm
Msps	megasamples per second
μΑ	microampere
μF	microfarad
μH	microhenry
μs	microsecond
μV	microvolt
μW	microwatt
mA	milliampere
ms	millisecond
mV	millivolt
nA	nanoampere
ns	nanosecond
nV	nanovolt
Ω	ohm
pF	picofarad
ppm	parts per million
ps	picosecond
S	second
sps	samples per second
sqrtHz	square root of hertz
V	volt

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